

NTMS4P01R2

Product Preview

Power MOSFET -4.5 Amps, -12 Volts P-Channel Enhancement-Mode Single SO-8 Package

Features

- High Density Power MOSFET with Ultra Low $R_{DS(on)}$ Providing Higher Efficiency
- Miniature SO-8 Surface Mount Package – Saves Board Space
- Diode Exhibits High Speed with Soft Recovery
- I_{DSS} Specified at Elevated Temperature
- Drain-to-Source Avalanche Energy Specified
- Mounting Information for the SO-8 Package is Provided

Applications

- Power Management in Portable and Battery-Powered Products, i.e.: Computers, Printers, PCMCIA Cards, Cellular & Cordless Telephones

MAXIMUM RATINGS

Please See the Table on the Following Page



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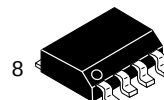
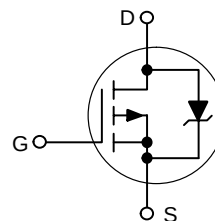
<http://onsemi.com>

-4.5 AMPERES

-12 VOLTS

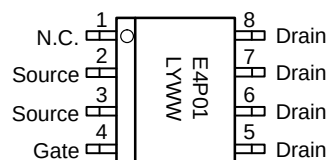
$0.045 \Omega @ V_{GS} = -4.5 V$

Single P-Channel



SO-8
CASE 751
STYLE 13

MARKING DIAGRAM & PIN ASSIGNMENT



Top View

E4P01 = Device Code
L = Assembly Location
Y = Year
WW = Work Week

ORDERING INFORMATION

Device	Package	Shipping
NTMS4P01R2	SO-8	2500/Tape & Reel

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	-12	V
Drain-to-Gate Voltage ($R_{GS} = 1.0\text{ m}\Omega$)	V_{DGR}	-12	V
Gate-to-Source Voltage – Continuous	V_{GS}	± 10	V
Thermal Resistance – Junction-to-Ambient (Note 1.)	$R_{\theta JA}$	50	$^\circ\text{C/W}$
Total Power Dissipation @ $T_A = 25^\circ\text{C}$	P_D	2.5	W
Continuous Drain Current @ 25°C	I_D	-6.04	A
Continuous Drain Current @ 70°C	I_D	-4.82	A
Maximum Operating Power Dissipation	P_D	1.2	W
Maximum Operating Drain Current	I_D	-4.18	A
Pulsed Drain Current (Note 4.)	I_{DM}	-20	A
Thermal Resistance – Junction-to-Ambient (Note 2.)	$R_{\theta JA}$	85	$^\circ\text{C/W}$
Total Power Dissipation @ $T_A = 25^\circ\text{C}$	P_D	1.47	W
Continuous Drain Current @ 25°C	I_D	-4.50	A
Continuous Drain Current @ 70°C	I_D	-3.65	A
Maximum Operating Power Dissipation	P_D	0.7	W
Maximum Operating Drain Current	I_D	-3.20	A
Pulsed Drain Current (Note 4.)	I_{DM}	-15	A
Thermal Resistance – Junction-to-Ambient (Note 3.)	$R_{\theta JA}$	159	$^\circ\text{C/W}$
Total Power Dissipation @ $T_A = 25^\circ\text{C}$	P_D	0.79	W
Continuous Drain Current @ 25°C	I_D	-3.40	A
Continuous Drain Current @ 70°C	I_D	-2.72	A
Maximum Operating Power Dissipation	P_D	0.38	W
Maximum Operating Drain Current	I_D	-2.32	A
Pulsed Drain Current (Note 4.)	I_{DM}	-12	A
Operating and Storage Temperature Range	T_J, T_{stg}	-55 to +150	$^\circ\text{C}$
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^\circ\text{C}$ ($V_{DD} = -12\text{ Vdc}$, $V_{GS} = -5.0\text{ Vdc}$, Peak $I_L = -8.0\text{ Apk}$, $L = 10\text{ mH}$, $R_G = 25\text{ }\Omega$)	E_{AS}	320	mJ
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T_L	260	$^\circ\text{C}$

1. Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), $t \leq 10$ seconds.
2. Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), $t = \text{steady state}$.
3. Minimum FR-4 or G-10 PCB, $t = \text{Steady State}$.
4. Pulse Test: Pulse Width = 300 μs , Duty Cycle = 2%.

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ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted) *

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage (V _{GS} = 0 Vdc, I _D = -250 μAdc) Temperature Coefficient (Positive)	V _{(BR)DSS}	-12 -	- -15	- -	Vdc mV/°C
Zero Gate Voltage Drain Current (V _{DS} = -12 Vdc, V _{GS} = 0 Vdc, T _J = 25°C) (V _{DS} = -12 Vdc, V _{GS} = 0 Vdc, T _J = 125°C)	I _{DSS}	- -	- -	-1.0 -10	μAdc
Gate-Body Leakage Current (V _{GS} = -10 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	-	-	-100	nAdc
Gate-Body Leakage Current (V _{GS} = +10 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	-	-	100	nAdc

ON CHARACTERISTICS

Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = -250 μAdc) Temperature Coefficient (Negative)	V _{GS(th)}	-0.65 -	-0.9 2.9	-1.15 -	Vdc mV/°C
Static Drain-to-Source On-State Resistance (V _{GS} = -4.5 Vdc, I _D = -4.5 Adc) (V _{GS} = -2.7 Vdc, I _D = -2.25 Adc) (V _{GS} = -2.5 Vdc, I _D = -2.25 Adc)	R _{DS(on)}	- - -	0.030 0.040 0.045	0.045 0.055 -	Ω
Forward Transconductance (V _{DS} = -2.5 Vdc, I _D = -2.25 Adc)	g _{FS}	-	10	-	Mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	(V _{DS} = -9.6 Vdc, V _{GS} = 0 Vdc, f = 1.0 MHz)	C _{iss}	-	1435	1850	pF
Output Capacitance		C _{oss}	-	635	1000	
Reverse Transfer Capacitance		C _{rss}	-	210	400	

SWITCHING CHARACTERISTICS (Notes 5. and 6.)

Turn-On Delay Time	(V _{DD} = -12 Vdc, I _D = -4.5 Adc, V _{GS} = -4.5 Vdc, R _G = 6.0 Ω)	t _{d(on)}	-	20	35	ns
Rise Time		t _r	-	60	100	
Turn-Off Delay Time		t _{d(off)}	-	65	100	
Fall Time		t _f	-	75	125	
Total Gate Charge	(V _{DS} = -9.6 Vdc, V _{GS} = -4.5 Vdc, I _D = -4.5 Adc)	Q _{tot}	-	20	35	nC
Gate-Source Charge		Q _{gs}	-	4.0	-	
Gate-Drain Charge		Q _{gd}	-	7.0	-	

BODY-DRAIN DIODE RATINGS (Note 5.)

Diode Forward On-Voltage (I _S = -4.5 Adc, V _{GS} = 0 V) (I _S = -4.5 Adc, V _{GS} = 0 Vdc, T _J = 125°C)	V _{SD}	- -	-0.9 -0.7	-1.25 -	Vdc
Reverse Recovery Time (I _S = -4.5 Adc, V _{GS} = 0 Vdc, di _S /dt = 100 A/μs)	t _{rr}	-	38	-	ns
	t _a	-	20	-	
	t _b	-	18	-	
Reverse Recovery Stored Charge	Q _{RR}	-	0.03	-	μC

5. Indicates Pulse Test: Pulse Width = 300 μs max, Duty Cycle = 2%.

6. Switching characteristics are independent of operating junction temperature.

* Handling precautions to protect against electrostatic discharge is mandatory.

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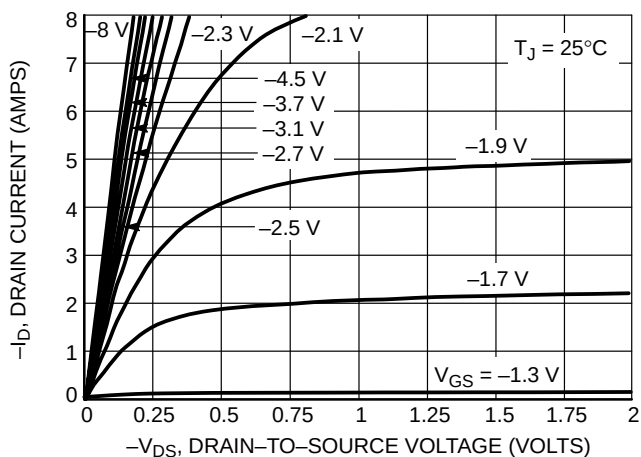


Figure 1. On-Region Characteristics

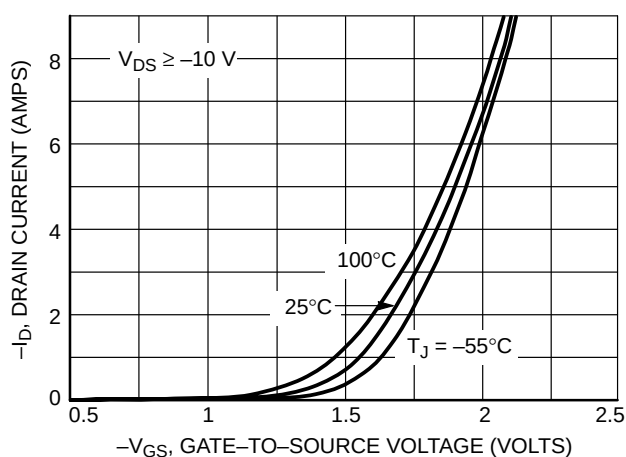


Figure 2. Transfer Characteristics

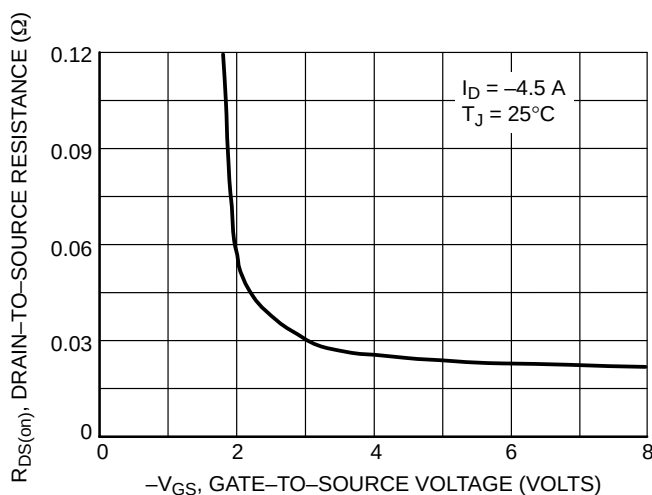


Figure 3. On-Resistance versus Gate-To-Source Voltage

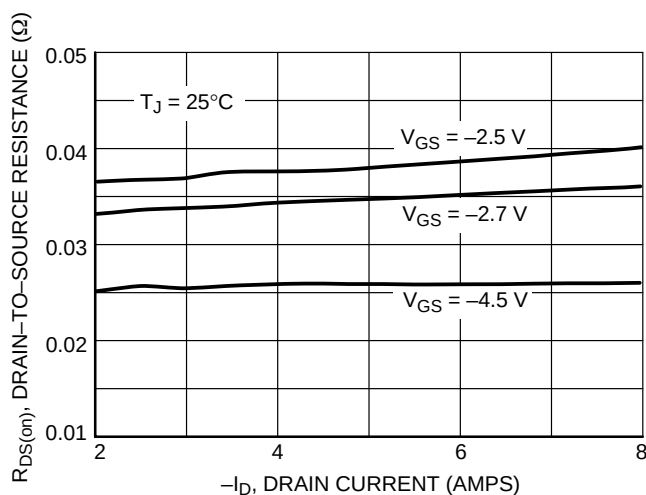


Figure 4. On-Resistance versus Drain Current and Gate Voltage

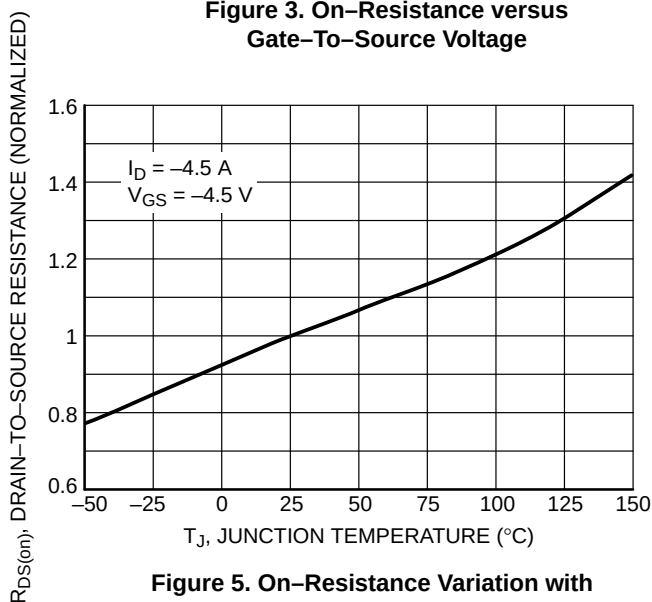


Figure 5. On-Resistance Variation with Temperature

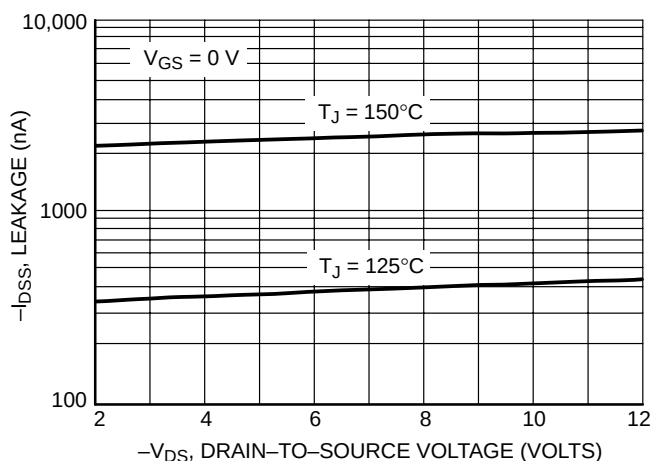


Figure 6. Drain-To-Source Leakage Current versus Voltage

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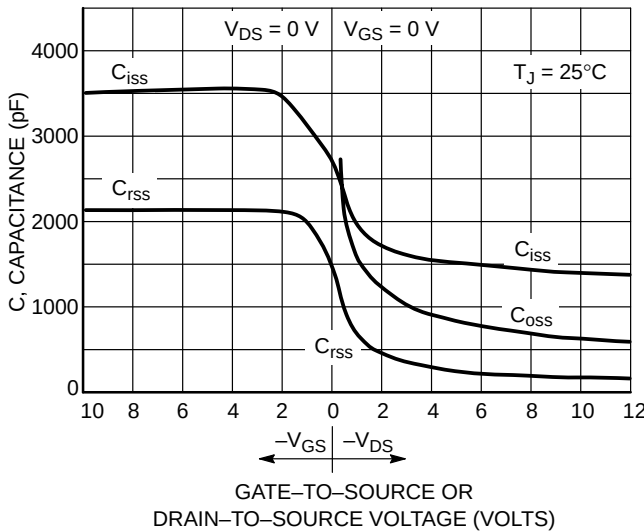


Figure 7. Capacitance Variation

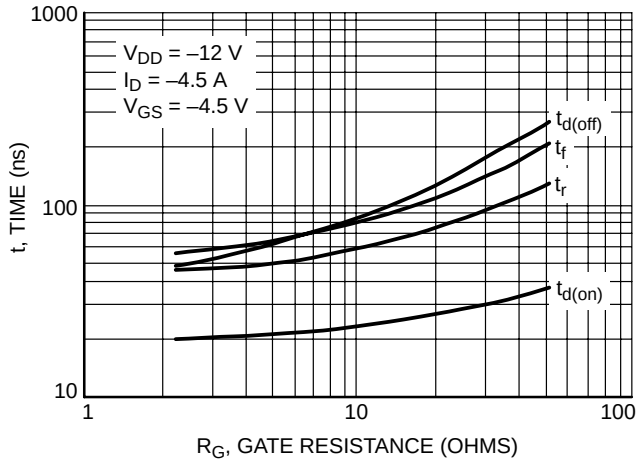


Figure 9. Resistive Switching Time Variation versus Gate Resistance

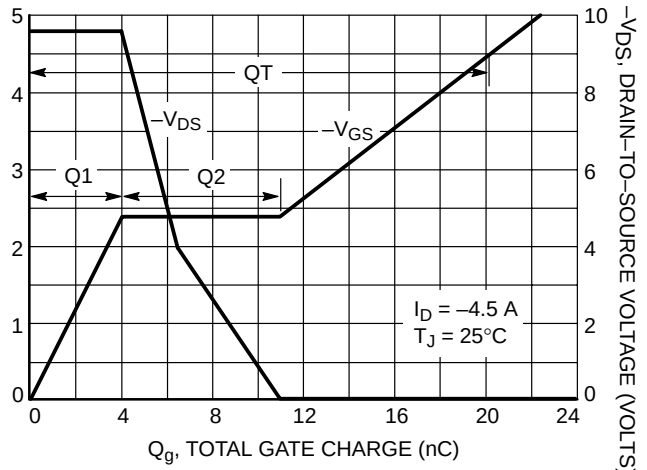


Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

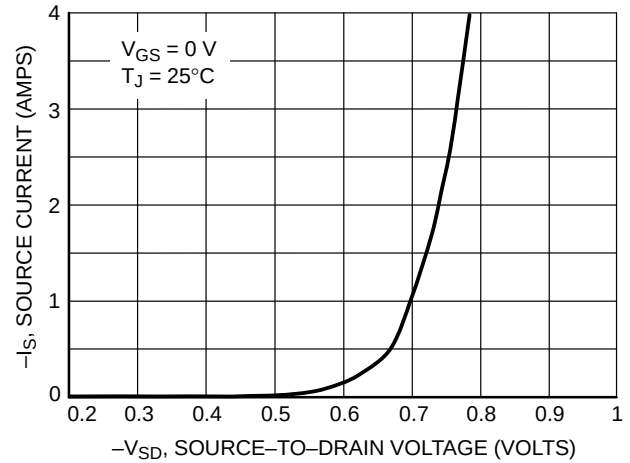


Figure 10. Diode Forward Voltage versus Current

DRAIN-TO-SOURCE DIODE CHARACTERISTICS

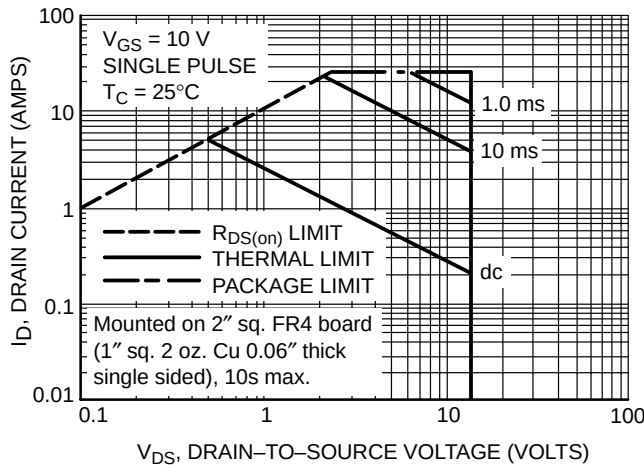


Figure 11. Maximum Rated Forward Biased Safe Operating Area

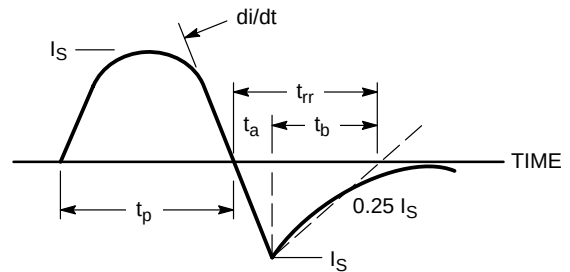


Figure 12. Diode Reverse Recovery Waveform

TYPICAL ELECTRICAL CHARACTERISTICS

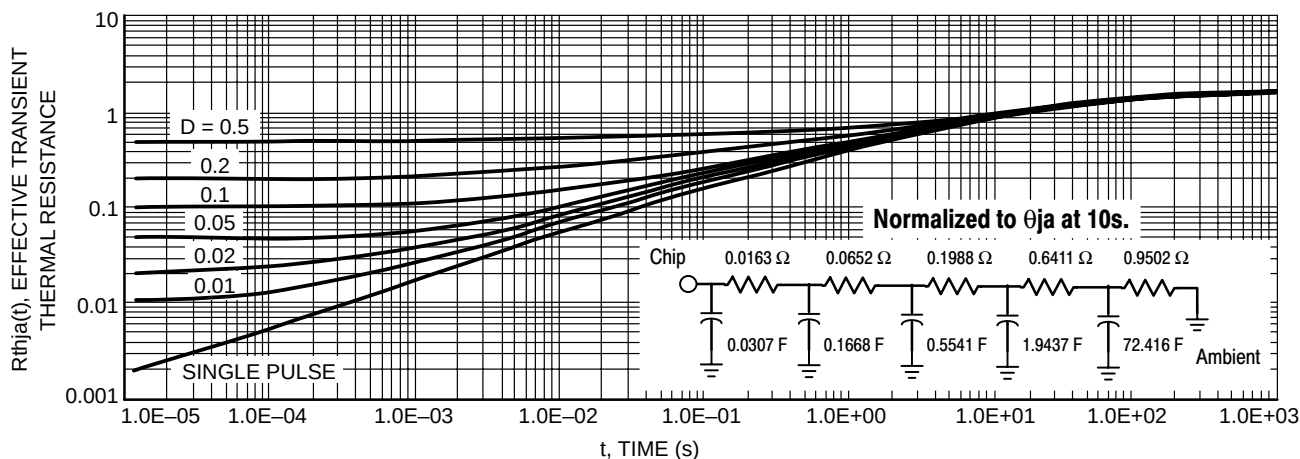


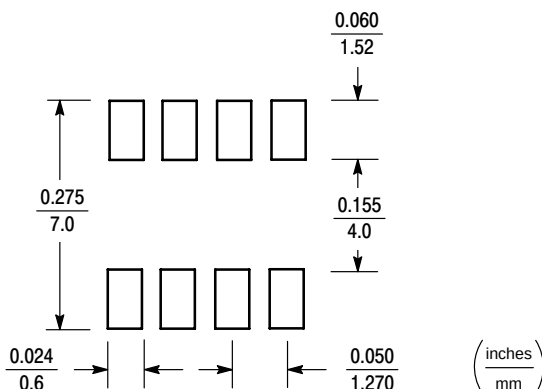
Figure 13. Thermal Response

INFORMATION FOR USING THE SO-8 SURFACE MOUNT PACKAGE

MINIMUM RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to ensure proper solder connection

interface between the board and the package. With the correct pad geometry, the packages will self-align when subjected to a solder reflow process.



SOLDERING PRECAUTIONS

The melting temperature of solder is higher than the rated temperature of the device. When the entire device is heated to a high temperature, failure to complete soldering within a short time could result in device failure. Therefore, the following items should always be observed in order to minimize the thermal stress to which the devices are subjected.

- Always preheat the device.
- The delta temperature between the preheat and soldering should be 100°C or less.*
- When preheating and soldering, the temperature of the leads and the case must not exceed the maximum temperature ratings as shown on the data sheet. When using infrared heating with the reflow soldering method, the difference shall be a maximum of 10°C.

- The soldering temperature and time shall not exceed 260°C for more than 10 seconds.
- When shifting from preheating to soldering, the maximum temperature gradient shall be 5°C or less.
- After soldering has been completed, the device should be allowed to cool naturally for at least three minutes. Gradual cooling should be used as the use of forced cooling will increase the temperature gradient and result in latent failure due to mechanical stress.
- Mechanical stress or shock should not be applied during cooling.

* Soldering a device without preheating can cause excessive thermal shock and stress which can result in damage to the device.

TYPICAL SOLDER HEATING PROFILE

For any given circuit board, there will be a group of control settings that will give the desired heat pattern. The operator must set temperatures for several heating zones and a figure for belt speed. Taken together, these control settings make up a heating “profile” for that particular circuit board. On machines controlled by a computer, the computer remembers these profiles from one operating session to the next. Figure 14 shows a typical heating profile for use when soldering a surface mount device to a printed circuit board. This profile will vary among soldering systems, but it is a good starting point. Factors that can affect the profile include the type of soldering system in use, density and types of components on the board, type of solder used, and the type of board or substrate material being used. This profile shows

temperature versus time. The line on the graph shows the actual temperature that might be experienced on the surface of a test board at or near a central solder joint. The two profiles are based on a high density and a low density board. The Vitronics SMD310 convection/infrared reflow soldering system was used to generate this profile. The type of solder used was 62/36/2 Tin Lead Silver with a melting point between 177–189°C. When this type of furnace is used for solder reflow work, the circuit boards and solder joints tend to heat first. The components on the board are then heated by conduction. The circuit board, because it has a large surface area, absorbs the thermal energy more efficiently, then distributes this energy to the components. Because of this effect, the main body of a component may be up to 30 degrees cooler than the adjacent solder joints.

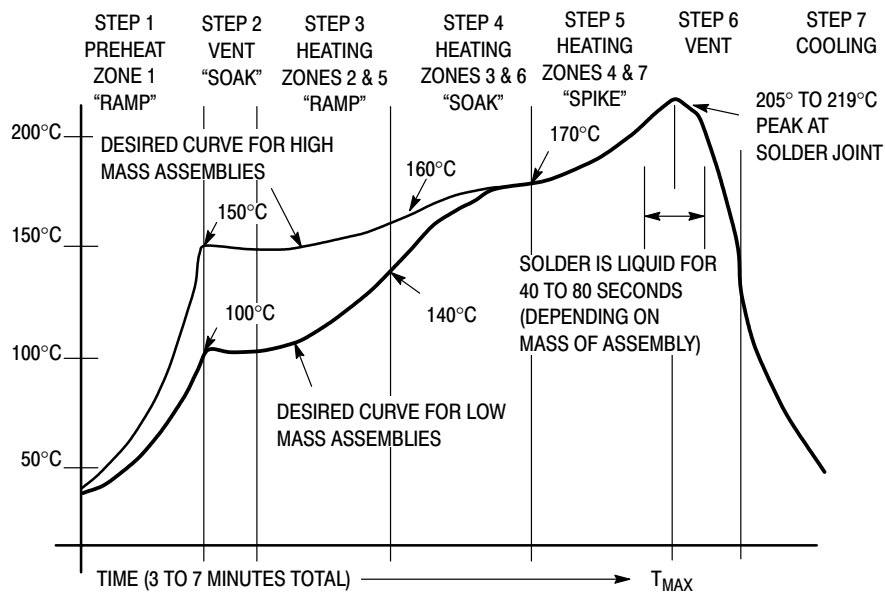
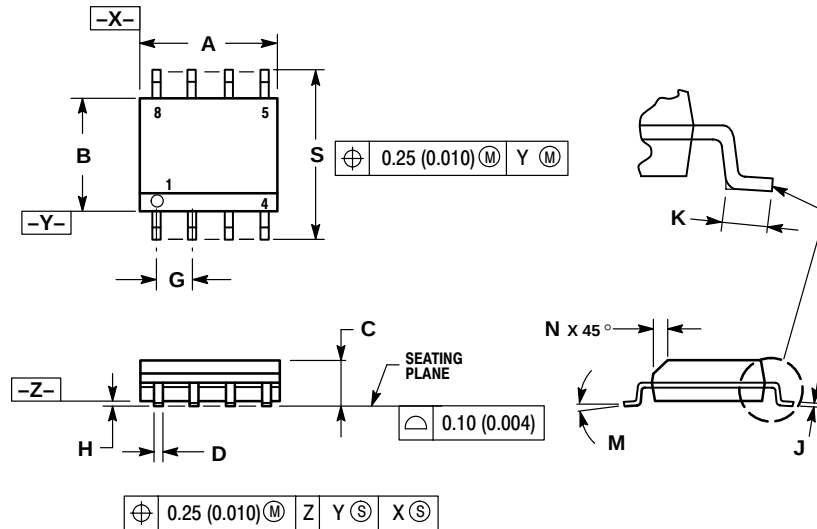


Figure 14. Typical Solder Heating Profile

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PACKAGE DIMENSIONS

SO-8 CASE 751-07 ISSUE V



NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.80	5.00	0.189	0.197
B	3.80	4.00	0.150	0.157
C	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27 BSC		0.050 BSC	
H	0.10	0.25	0.004	0.010
J	0.19	0.25	0.007	0.010
K	0.40	1.27	0.016	0.050
M	0°	8°	0°	8°
N	0.25	0.50	0.010	0.020
S	5.80	6.20	0.228	0.244

STYLE 13:

- PIN 1: N.C.
 2. SOURCE
 3. SOURCE
 4. GATE
 5. DRAIN
 6. DRAIN
 7. DRAIN
 8. DRAIN

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